	Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/829,141	KIM ET AL.	
Examiner	Art Unit	_
Joseph Nguyen	2815	

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Class	Subclass	Date	Examiner
257	627-628	8/4/2005	JN
257	101	8/4/2005	JN
257	e33.008	8/4/2005	JN
257	e33.003	8/4/2005	. JN

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